

# MOS FIELD EFFECT TRANSISTOR 2SK3056

## SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

#### **DESCRIPTION**

This product is N-Channel MOS Field Effect Transistor designed for high current switching applications.

#### **FEATURES**

• Low On-State Resistance

 $R_{\text{DS(on)1}} = 34~\text{m}\Omega$  MAX. (VGs = 10 V, ID = 16 A)

RDS(on)2 = 50 m $\Omega$  MAX. (VGS = 4.0 V, ID = 16 A)

- Low Ciss : Ciss = 920 pF TYP.
- Built-in Gate Protection Diode

#### **ORDERING INFORMATION**

PART NUMBER	PACKAGE
2SK3056	TO-220AB
2SK3056-S	TO-262
2SK3056-ZJ	TO-263

#### ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Drain to Source Voltage (Vgs = 0 V)	VDSS	60	V
Gate to Source Voltage (Vps = 0 V)	VGSS(AC)	±20	V
Gate to Source Voltage (Vps = 0 V)	VGSS(DC)	+20, -10	V
Drain Current (DC)	ID(DC)	±32	Α
Drain Current (Pulse) Note1	D(pulse)	±100	Α
Total Power Dissipation (Tc = 25°C)	Рт	34	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	Рт	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current Note2	las	16	Α
Single Avalanche Energy Note2	Eas	25.6	mJ

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty cycle  $\leq$  1 %

2. Starting Tch = 25 °C, Rg = 25  $\Omega$ , Vgs = 20 V  $\rightarrow$  0 V

#### THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	3.68	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

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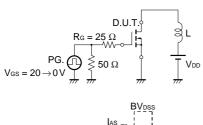
Not all devices/types available in every country. Please check with local NEC representative for availability and additional information.

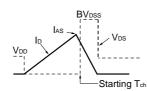


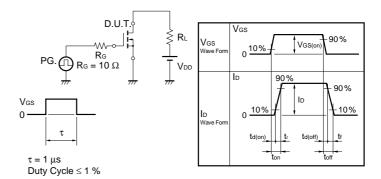
#### **ELECTRICAL CHARACTERISTICS (TA = 25 °C)**

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CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Drain to Source On-state Resistance	RDS(on)1	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 16 A		24	34	mΩ
	RDS(on)2	Vgs = 4.0 V, lb = 16 A		35	50	mΩ
Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.0	1.5	2.0	V
Forward Transfer Admittance	yfs	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 16 A	8.0	20		S
Drain Leakage Current	Inss	V <sub>DS</sub> = 60 V, V <sub>GS</sub> = 0 V			10	μΑ
Gate to Source Leakage Current	Igss	Vgs = ±20 V, Vps = 0 V			±10	μΑ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		920		рF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		280		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		120		рF
Turn-on Delay Time	td(on)	ID = 16 A		25		ns
Rise Time	tr	V <sub>GS(on)</sub> = 10 V		300		ns
Turn-off Delay Time	td(off)	V <sub>DD</sub> = 30 V		70		ns
Fall Time	tf	$R_G = 10 \Omega$		120		ns
Total Gate Charge	Q <sub>G</sub>	ID = 32 A		25		nC
Gate to Source Charge	Qgs	V <sub>DD</sub> = 48 V		3.3		nC
Gate to Drain Charge	Q <sub>GD</sub>	V <sub>GS</sub> = 10 V		7.0		nC
Body Diode Forward Voltage	VF(S-D)	IF = 32 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	If = 32A, V <sub>G</sub> s = 0 V		50		ns
Reverse Recovery Charge	Qrr	di/dt = 100A/μs		68		nC

#### **TEST CIRCUIT 1 AVALANCHE CAPABILITY**





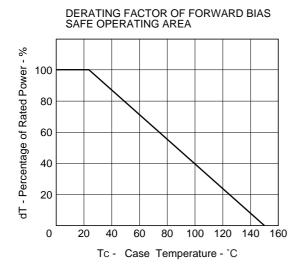


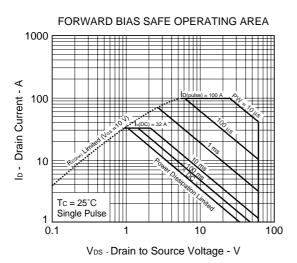
**TEST CIRCUIT 2 SWITCHING TIME** 

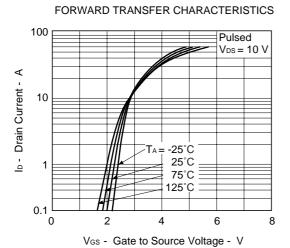
#### **TEST CIRCUIT 3 GATE CHARGE**

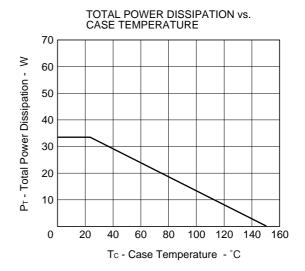


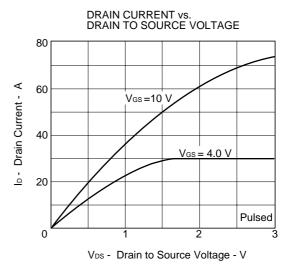
#### TYPICAL CHARACTERISTICS (TA = 25 °C)



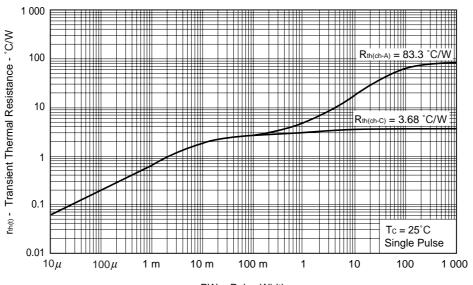




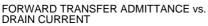


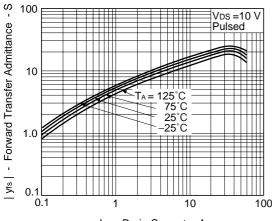


#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

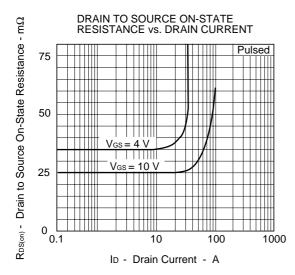


PW - Pulse Width - s

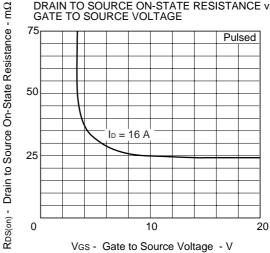




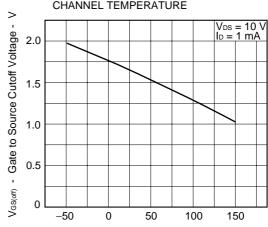
ID - Drain Current - A



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

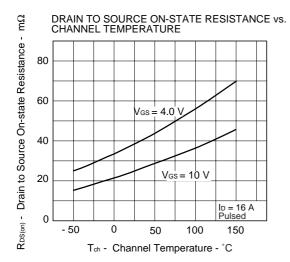


GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE

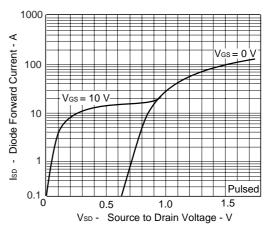


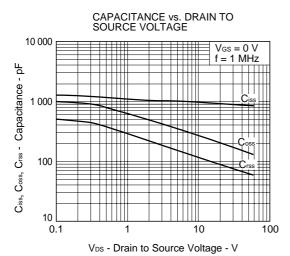
Tch - Channel Temperature - °C



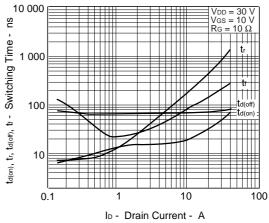


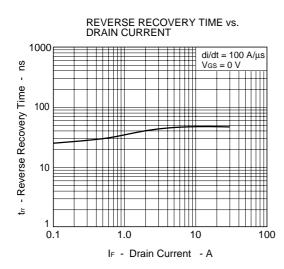
#### SOURCE TO DRAIN DIODE FORWARD VOLTAGE

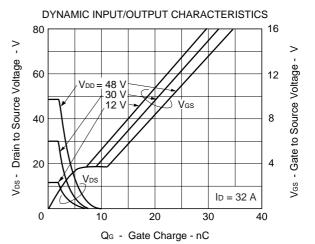




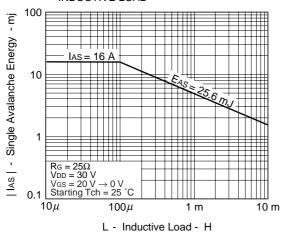




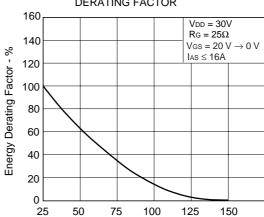




## SINGLE AVALANCHE ENERGY vs. INDUCTIVE LOAD



## SINGLE AVALANCHE ENERGY DERATING FACTOR

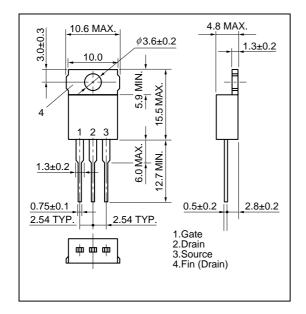


Starting Tch - Starting Channel Temperature - °C

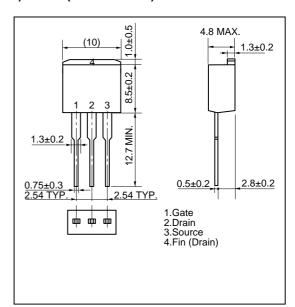


#### PACKAGE DRAWINGS (Unit: mm)

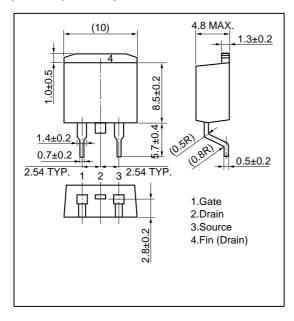
#### 1)TO-220AB (MP-25)



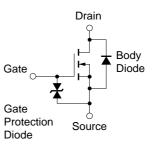
#### 2)TO-262 (MP-25 Fin Cut)



#### 3)TO-263 (MP-25ZJ)



#### **EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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